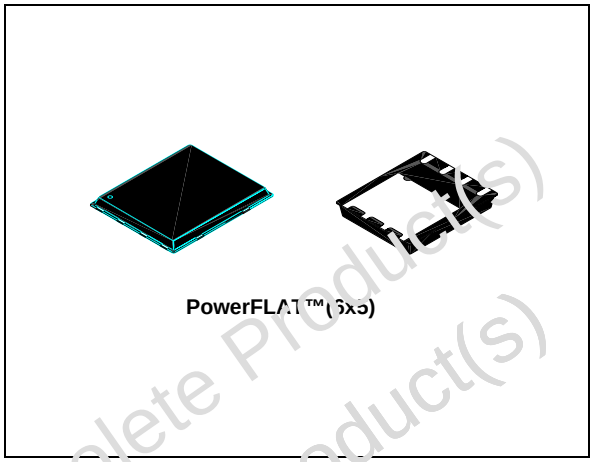
STL55NH3LL

N-channel 30 V, 0.0079 Ω, 15 A, PowerFLAT™ (6x5) ultra low gate charge STripFET™ Power MOSFET

Features

Type	V_{DSS}	$R_{DS(on)}$ max	I_D
STL55NH3LL	30 V	< 0.0088 Ω	15 A

- Improved die-to-footprint ratio
- Very low profile package (1mm max)
- Very low thermal resistance
- Very low gate charge
- Low threshold device



Application

- Switching applications

Description

This application specific Power MOSFET is the latest generation of STMicroelectronics unique "STripFET™" technology. The resulting transistor is optimized for low on-resistance and minimal gate charge. The chip scaled PowerFLAT™ package allows a significant board space saving, still boosting the performance.

Figure 1. Internal schematic diagram

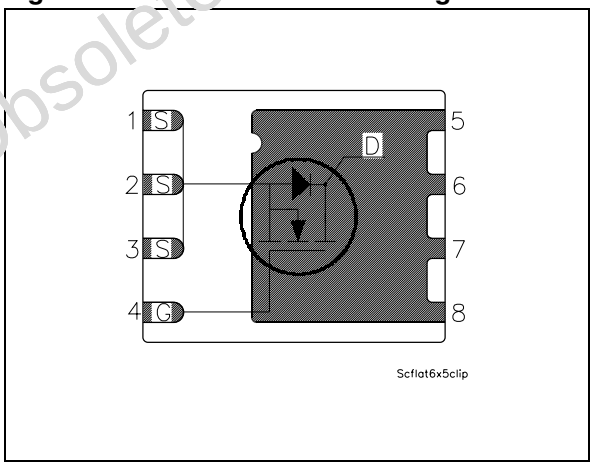


Table 1. Device summary

Order code	Marking	Package	Packaging
STL55NH3LL	L55NH3LL	PowerFLAT™ (6x5)	Tape and reel

Obsolete Product(s) - Obsolete Product(s)

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Obsolete Product(s) - Obsolete Product(s)
Obsolete Product(s) - Obsolete Product(s)

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V_{GS} = 0)	30	V
V_{GS}(1)	Gate-source voltage	± 16	V
V_{GS}(2)	Gate-source voltage	± 18	V
I_D(3)	Drain current (continuous) at T_C = 25 °C	55	A
I_D(3)	Drain current (continuous) at T_C=100 °C	36	A
I_{DM}(4)	Drain current (pulsed)	60	A
I_D (5)	Drain current (continuous) at T_C = 25 °C	15	A
I_D (5)	Drain current (continuous) at T_C=100 °C	9.4	A
P_{TOT} (5)	Total dissipation at T_C = 25 °C	4	W
P_{TOT} (3)	Total dissipation at T_C = 25 °C	60	W
	Derating factor	0.03	W/°C
T_J T_{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

1. Continuous mode
2. Guaranteed for test time ≤ 15 ms
3. The value is rated according R_{thj-c}
4. Pulse width limited by safe operating area
5. The value is rated according $R_{thj-pcb}$

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case (drain)	2.08	°C/W
$R_{thj-pcb}$ (1)	Thermal resistance junction-ambient	31.3	°C/W

1. When mounted on FR-4 board of 1inch², 2oz Cu, t < 10 sec

Table 4. Avalanche data

Symbol	Parameter	Value	Unit
I_{AV}	Not-repetitive avalanche current (pulse width limited by Tj Max)	7.5	A
E_{AS}	Single pulse avalanche energy (starting Tj = 25 °C, I_D=I_{AV}, V_{DD} = 24 V, L=6 mH)	150	mJ

Obsolete Product(s) - Obsolete Product(s)

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	I_D = 250 µA, V_{GS}= 0	30			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = max rating, V_{DS} = max rating @125 °C			1 10	µA µA
I_{GSS}	Gate body leakage current (V_{DS} = 0)	V_{GS} = ±16 V			±100	nA
$V_{GS(th)}$	Gate threshold voltage	V_{DS}= V_{GS}, I_D = 250 µA	1		2.5	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS}= 10 V, I_D= 7.5 A V_{GS}= 8 V, I_D= 7.5 A V_{GS}= 4.5 V, I_D= 7.5 A		0.0079 0.0079 0.009	0.0088 0.0088 0.0115	Ω Ω Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} = 25 V, f=1 MHz, V_{GS}=0		965 285 38		pF pF pF
Q_g Q_{gs} Q_{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD}=15 V, I_D = 15 A V_{GS} =4.5 V *(see Figure 16)*		9 3.7 3	12	nC nC nC
Q_{gs1} Q_{gs2}	Pre V_{th} gate-to-source charge Post V_{th} gate-to-source charge	V_{DD}=15 V, I_D = 15 A V_{GS} =4.5 V		2.5 1.2		nC nC
R_G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	0.5	1.5	2.5	Ω

Obsolete Product(s) - Obsolete Product(s)

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD}=15 V, I_D= 7.5 A, R_G=4.7 Ω, V_{GS}=4.5 V *(see Figure 18)*		15 32 18 8.5		ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
I_{SD}	Source-drain current				5	A
I_{SDM}(1)	Source-drain current (pulsed)				60	A
V_{SD}(2)	Forward on voltage	I_{SD}=15 A, V_{GS}=0			1.3	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD}=15 A, di/dt = 100 A/µs, V_{DD}=20 V, T_j= 150 °C *(see Figure 17)*		24 17.4 1.45		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300 µs, duty cycle 1.5%

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Obsolete Product(s) - Obsolete Product(s)

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

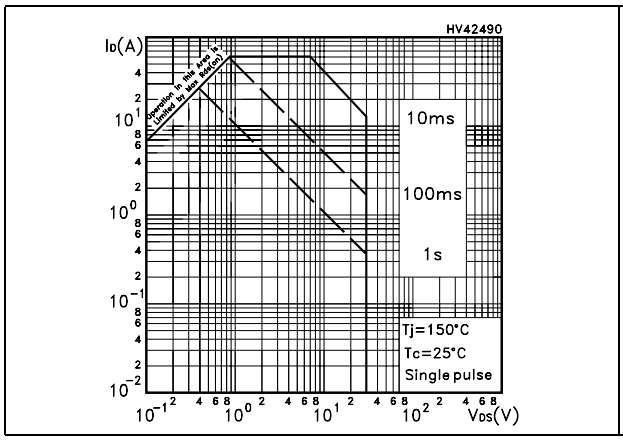


Figure 3. Thermal impedance

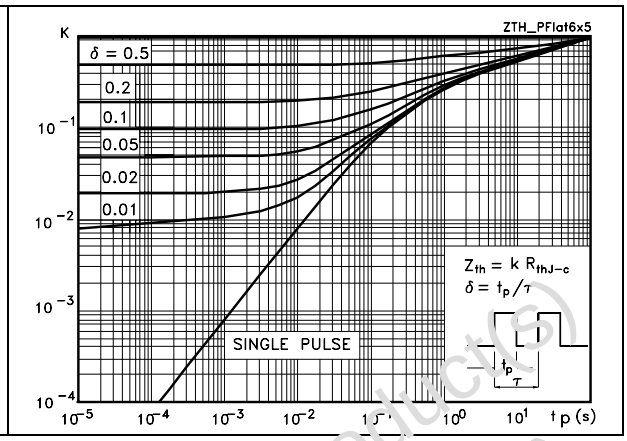


Figure 4. Output characteristics

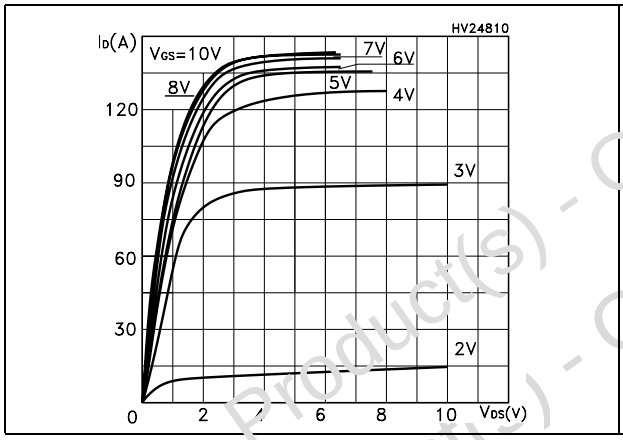


Figure 5. Transfer characteristics

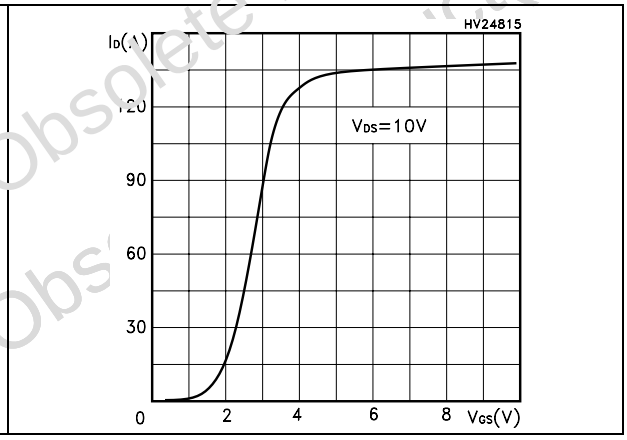


Figure 6. Normalized B_{VDSS} vs temperature

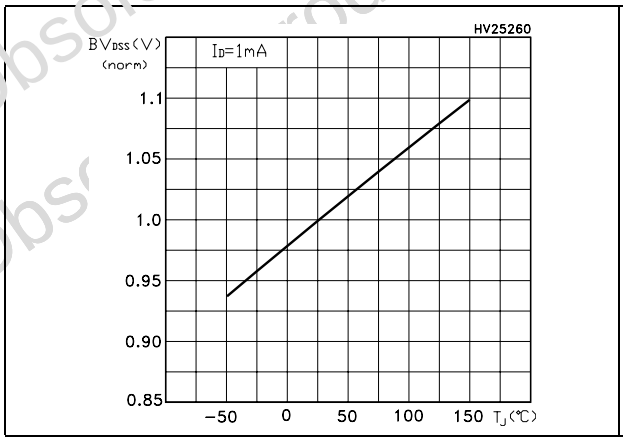
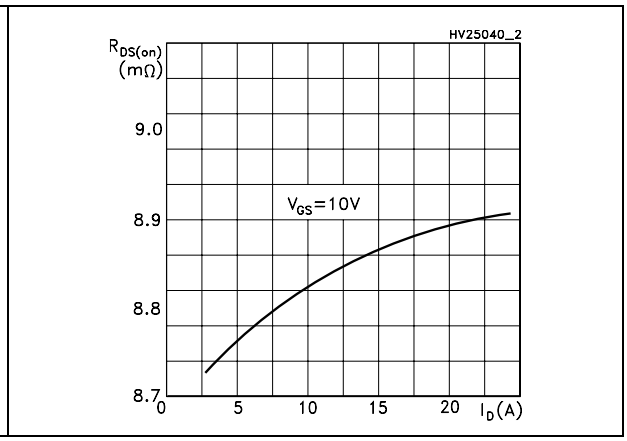


Figure 7. Static drain-source on resistance



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Figure 8. Gate charge vs gate-source voltage

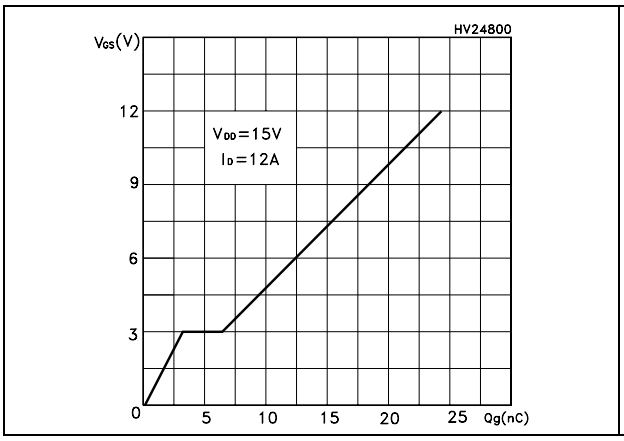


Figure 9. Capacitance variations

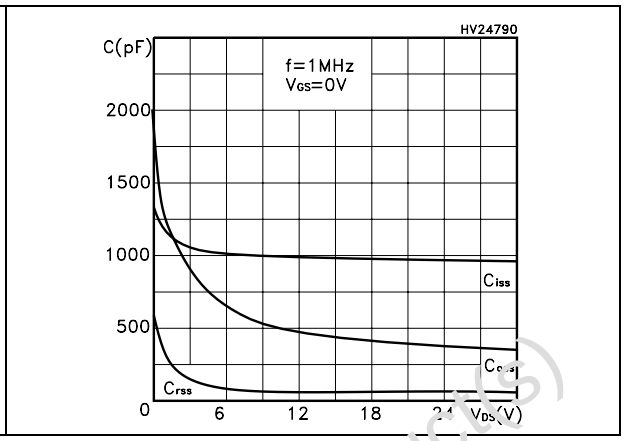


Figure 10. Normalized gate threshold voltage vs temperature

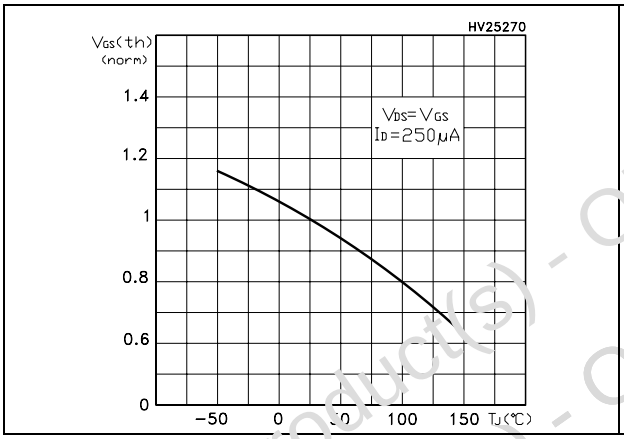


Figure 11. Normalized on resistance vs temperature

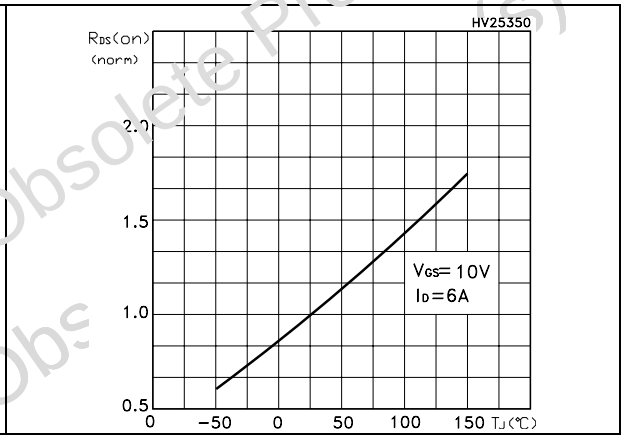


Figure 12. Source-drain diode forward characteristics

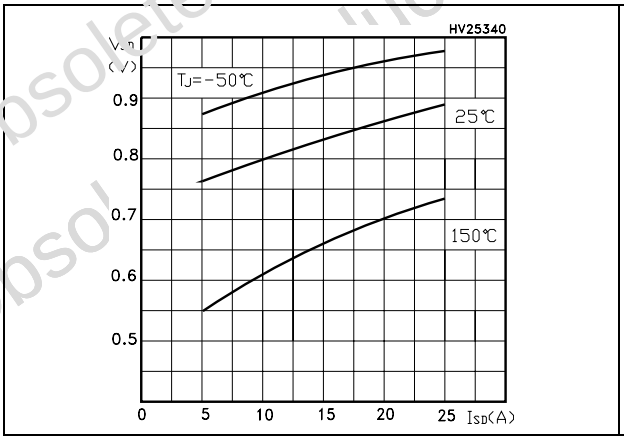
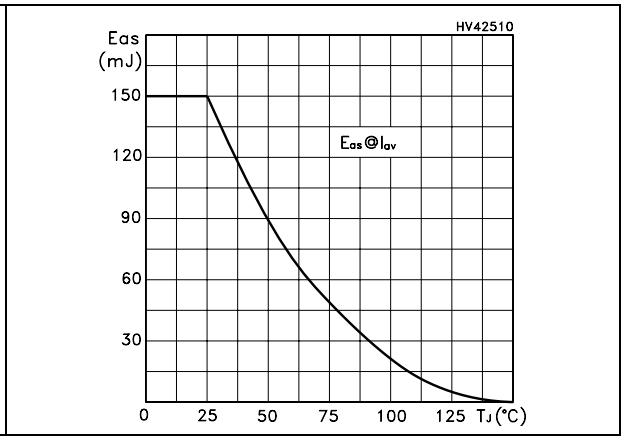
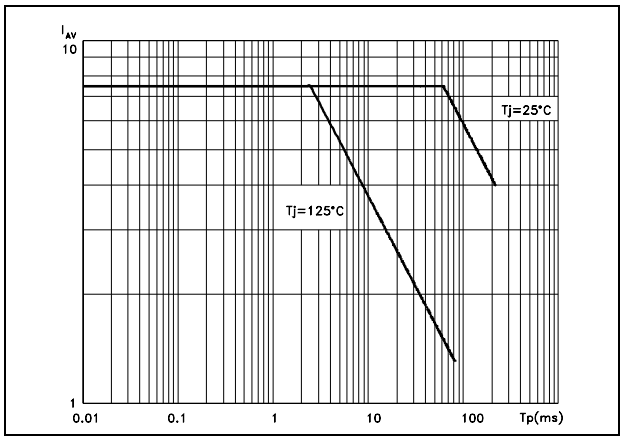


Figure 13. Avalanche energy vs starting t_j



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Figure 14. Allowable I_{av} vs time in avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

$P_{D(AVE)} = 0.5*(1.3*B_{VDSS} *I_{AV})$

$E_{AS(AR)} = P_{D(AVE)} *t_{AV}$

Where:

I_{AV} is the allowable current in avalanche

$P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

t_{AV} is the time in avalanche

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3 Test circuits

Figure 15. Switching times test circuit for resistive load

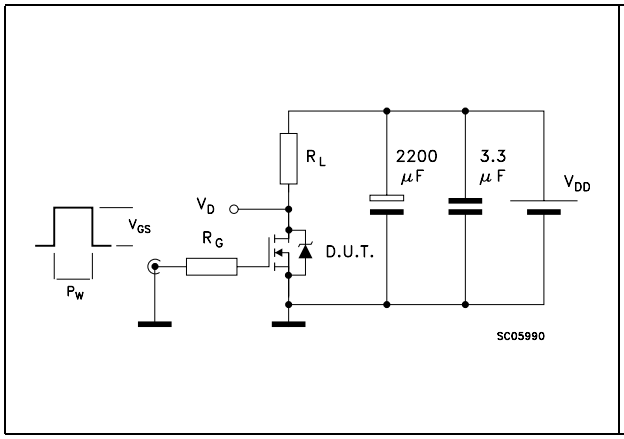


Figure 16. Gate charge test circuit

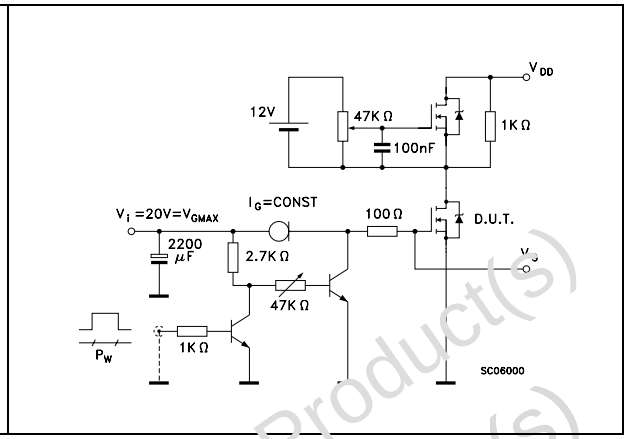


Figure 17. Test circuit for inductive load switching and diode recovery times

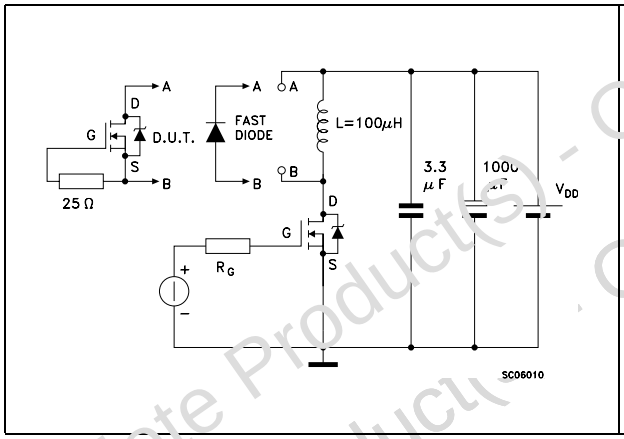


Figure 18. Unclamped inductive load test circuit

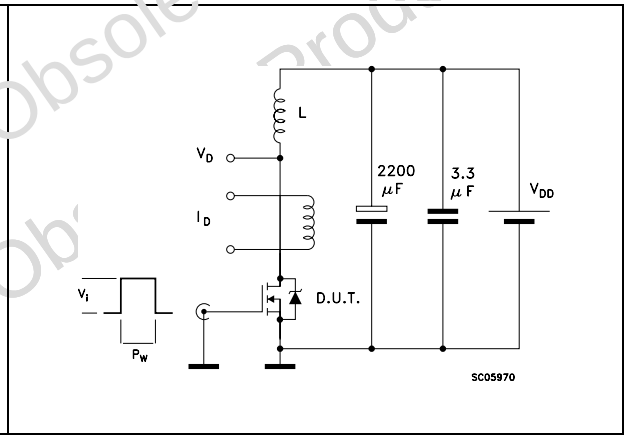


Figure 19. Unclamped inductive waveform

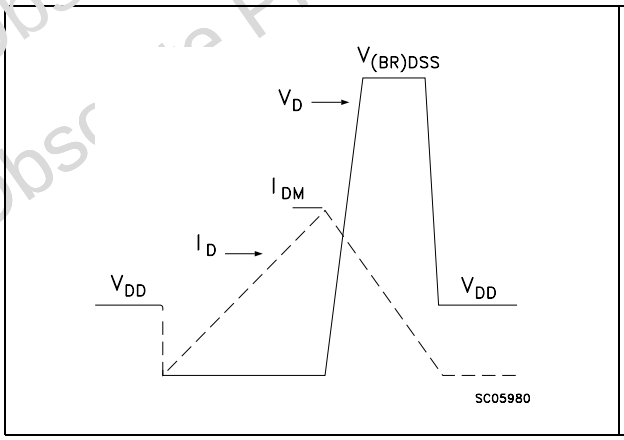
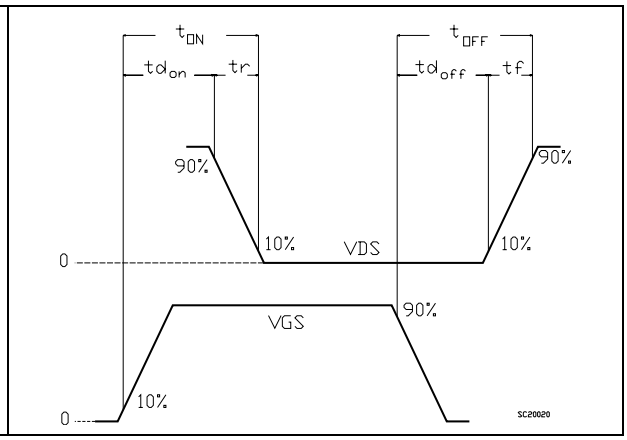
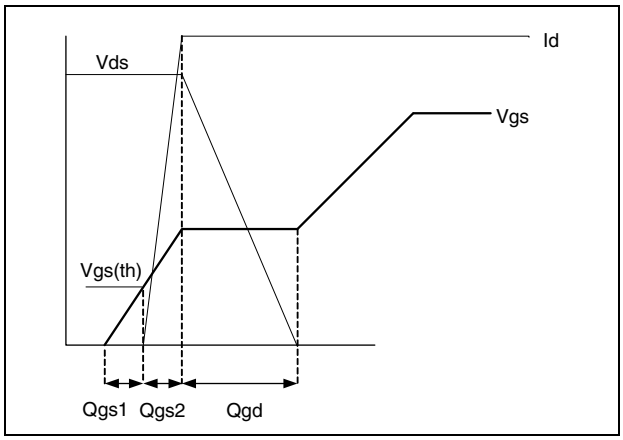


Figure 20. Switching time waveform



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Figure 21. Gate charge waveform



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Obsolete Product(s) - Obsolete Product(s)

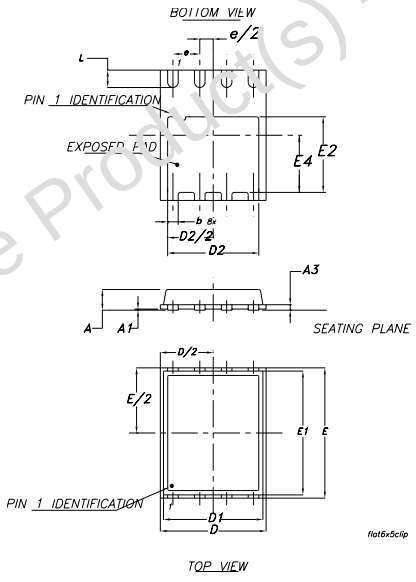
4 Package mechanical data

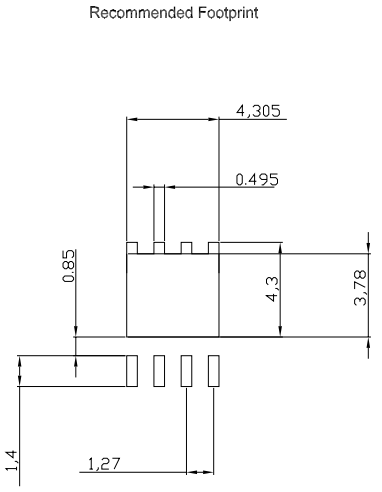
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PowerFLAT™ (6x5) MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
E		6.00			0.236	
E1		5.75			0.22[illegible]	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
e		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035





Note: all dimentions are in mm.

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5 Revision history

Table 9. Document revision history

Date	Revision	Changes
18-Mar-2008	1	First release.
05-May-2008	2	Corrected *Table 1: Device summary*
07-May-2008	3	Update *Figure 6: Normalized B_{VDSS} vs temperature*

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